

FORM PTO-1449

LIST OF REFERENCES CITED BY APPLICANT

ATTY. DOCKET NO.

VTE-111-D

SERIAL NO.

09/772,273

APPLICANT

Jeff Moler et al.

FILING DATE

January 29, 2001

GROUP

2834

U. S. PATENT DOCUMENT

EXAMINER INITIALS	PATENT NO.	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE
AB	AA 3,731,214	5/1/1973	Bers			
	AB 3,649,857	3/14/1972	Knappe			
	AC 3,558,936	1/26/1971	Horan			
	AD 3,548,314	12/15/1970	Mitchell			
	AE 3,513,309	5/19/1970	Hehemann			
	AF 3,446,920	5/27/1969	Zuerkr			
	AG 3,421,109	1/7/1969	Wiggins et al.			
	AH 3,414,779	12/3/1968	Bohm			
	AI Re. 34,823	1/10/1995	Sakaida et al.			
	AJ 3,405,289	10/8/1968	Gikow			

FOREIGN PATENT OR PUBLISHED PATENT APPLICATION

DOCUMENT NO.	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION
AL JP6105568	1994-04-15	Japan			
AM JP62217880	1987-09-25	Japan			
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

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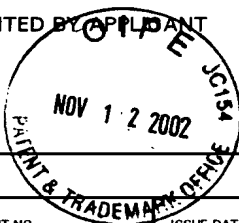
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<i>[Signature]</i>	AA	4,769,569	9/6/1988	Stahlhuth			
	AB	4,703,215	10/27/1987	Asano			
	AC	4,675,568	6/23/1987	Uchikawa et al.			
	AD	4,647,808	3/3/1987	Shibuya			
	AE	4,629,039	12/16/1986	Imoto et al.			
	AF	4,570,095	2/11/1986	Uchikawa			
	AG	4,460,840	7/17/1984	Weiger et al.			
	AH	4,435,666	3/6/1984	Fukui et al.			
	AI	4,318,023	3/2/1982	O'Neill et al.			
	AJ	4,287,582	9/1/1981	Tocquet			
	AK	4,214,215	7/22/1980	Mellen et al.			
	AL	4,193,703	3/18/1980	Kakmann			
	AM	4,009,447	2/22/1977	Wolf et al.			
<i>[Signature]</i>	AN	3,749,946	7/31/1973	Von Ruti			

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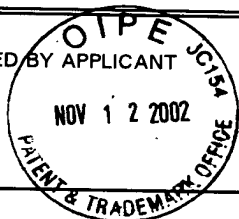
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<i>[Signature]</i>	AA	4,979,275	12/25/1990	Sakaida et al.			
	AB	4,937,489	6/26/1990	Hattori et al.			
	AC	4,933,591	6/12/1990	Stahlhuth			
	AD	4,929,859	5/29/1990	Suzuki et al.			
	AE	4,874,980	10/17/1989	Mine et al.			
	AF	4,874,978	10/17/1989	Sakaida et al.			
	AG	4,847,193	7/11/1989	Richards et al.			
	AH	4,835,747	5/30/1989	Billet			
	AI	4,816,713	3/28/1989	Change, Jr.			
	AJ	4,808,874	2/28/1989	Stahlhuth			
<i>[Signature]</i>	AK	4,783,610	11/8/1988	Asano			

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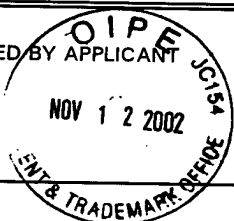
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<i>TS</i>	AA	5,444,324	8/22/1995	Priest et al.			
	AB	5,410,207	4/25/1995	Miura et al.			
	AC	5,270,984	12/14/1993	Mine			
	AD	5,239,904	8/31/1993	Yamaguchi et al.			
	AE	5,205,147	4/27/1993	Wada et al.			
	AF	5,191,252	3/2/1993	Sano			
	AG	5,115,880	5/26/1992	Sallas et al.			
	AH	5,078,241	1/7/1992	Ackermann et al.			
	AI	5,063,542	11/5/1991	Petermann et al.			
	AJ	5,028,834	7/2/1991	Sakaida et al.			
<i>TS</i>	AK	5,004,946	4/2/1991	Sakaida et al.			
	AL	4,999,284	3/12/1991	Ward et al.			

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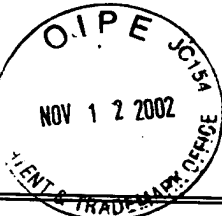
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1/11	AA	6,411,009	6/25/2002	Jaenker			
	AB	6,294,859	9/25/2001	Jaenker			
	AC	6,291,928	9/18/2001	Lazarus et al.			
	AD	6,246,287	6/12/2001	Yamashita			
	AE	6,131,879	10/17/2000	Kluge et al.			
	AF	6,003,836	12/21/1999	Cewers			
	AG	5,907,211	5/25/1999	Hall et al.			
	AH	5,859,561	1/12/1999	Vanoli			
	AI	5,779,149	7/14/1998	Hayes Jr.			
1/11	AJ	5,501,986	3/26/1996	Ward et al.			
	AK	5,479,064	12/26/1995	Sano			

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